

General Description :

HMM150N15 , the silicon N-channel Enhanced VDMOSFET, is obtained by the Super Trench technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is Sot-227B, which accords with the RoHS standard.

Features :

- Fast Switching
- ESD Improved Capability
- Low Gate Charge
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test

Applications:

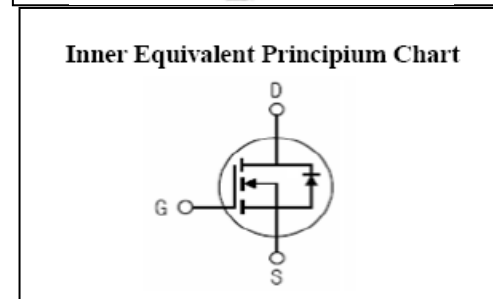
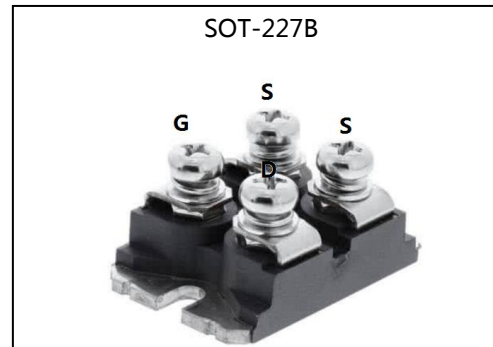
- Power switch circuit of POWER

Absolute (Tc=25°C unless otherwise specified) :

Symbol	Parameter	Rating	Units
V _{DSS}	Drain-to-Source Voltage	150	V
I _D	Continuous Drain Current	150	A
	Continuous Drain Current T _C =100 °C	110	A
I _{DM} ^{a1}	Pulsed Drain Current(pulse width limited by T _{JM})	380	A
V _{GS}	Gate-to-Source Voltage	±20	V
E _{AS}	Single Pulse Avalanche Energy	1300	mJ
E _{AR} ^{a1}	Avalanche Energy ,Repetitive	100	mJ
I _{AR} ^{a1}	Avalanche Current	60	A
dv/dt ^{a2}	Peak Diode Recovery dv/dt	5.0	V/ns
P _D	Power Dissipation	680	W
	Derating Factor above 25°C	5.44	W/°C
T _J , T _{stg}	Operating Junction and Storage Temperature Range	150 , -55 to 175	°C
T _L	Maximum Temperature for Soldering	300	°C

Caution Stresses greater than those in the "Absolute Maximum Ratings" may cause permanent damage to the device

V _{DSS} (T _C =150°C)	150	V
I _D	150	A
P _D (T _C =25°C)	680	W
R _{DS(ON)MAX}	8	mΩ



Thermal Characteristics

Symbol	Parameter	Rating	Units
R_{thJC}	Thermal Resistance, Junction-to-Case	0.184	°C/ W
R_{thcs}	Thermal Resistance, Case to heatsink	0.1	°C/ W

Electrical Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified) :

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V_{DSS}	Drain to Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	150	--	--	V
I_{DSS}	Drain to Source Leakage Current	$V_{DS}=150V, V_{GS}=0V, T_a=25^\circ\text{C}$	--	--	10	μA
		$V_{DS}=120V, V_{GS}=0V, T_a=125^\circ\text{C}$	--	--	100	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+20V$	--	--	100	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-20V$	--	--	-100	nA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=10V, I_D=90A$	--	6.0	8.0	m Ω
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	2.0	--	4.0	V
g_{fs}	Forward Trans conductance	$V_{DS}=10V, I_D=70A$	70	--	--	S

Pulse width < 380 μ s; duty cycle < 2%.

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
C_{iss}	Input Capacitance	$V_{GS}=0V, V_{DS}=75V$ $f=1.0\text{MHz}$	--	5900	--	pF
C_{oss}	Output Capacitance		--	690	--	
C_{rss}	Reverse Transfer Capacitance		--	7	--	pF

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$I_D=70A, V_{DD}=75V$ $V_{GS}=10V, R_g=4.7\Omega$	--	26	--	ns
t_r	Rise Time		--	36	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	47	--	
t_f	Fall Time		--	15	--	
Q_g	Total Gate Charge	$I_D=70A, V_{DD}=75V$ $V_{GS}=10V$	--	80	--	nC
Q_{gs}	Gate to Source Charge		--	32	--	
Q_{gd}	Gate to Drain ("Miller") Charge		--	13	--	

Source-Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I_{SD}	Continuous Source Current (Body Diode)		--	--	150	A
I_{SM}	Maximum Pulsed Current (Body Diode)		--	--	380	A
V_{SD}	Diode Forward Voltage	$I_S=150A, V_{GS}=0V$	--	--	1.5	V
t_{rr}	Reverse Recovery Time	$I_S=50A, T_j=25^{\circ}C$	--	155	--	ns
Q_{rr}	Reverse Recovery Charge	$dI_F/dt=100A/\mu s,$ $V_{GS}=0V$	--	520	--	nC

a1 : Repetitive rating; pulse width limited by maximum junction temperature

a2 : $I_{SD}=150A, di/dt \leq 100A/\mu s, V_{DD} \leq BV_{DS},$ Start $T_j=25^{\circ}C$

Characteristics Curve :

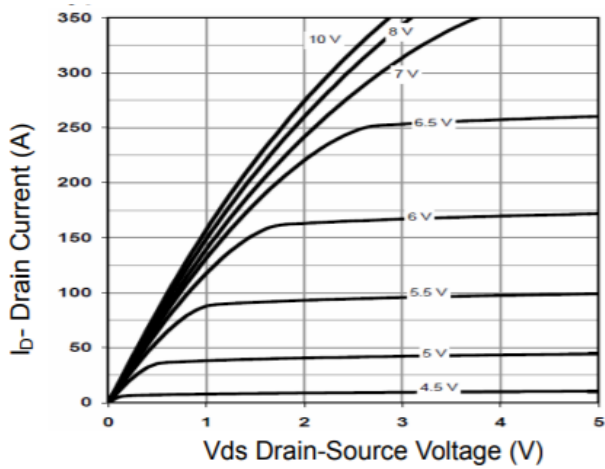


Figure 1 Output Characteristics

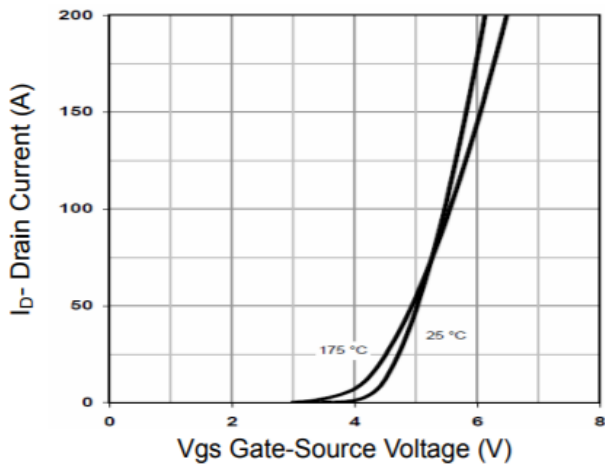


Figure 2 Transfer Characteristics

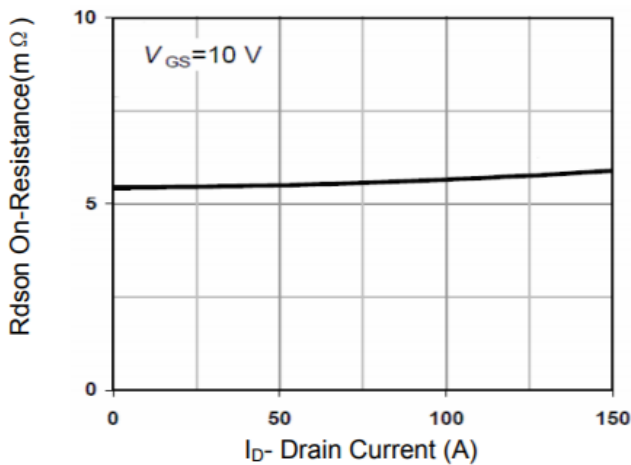


Figure 3 Rds(on)- Drain Current

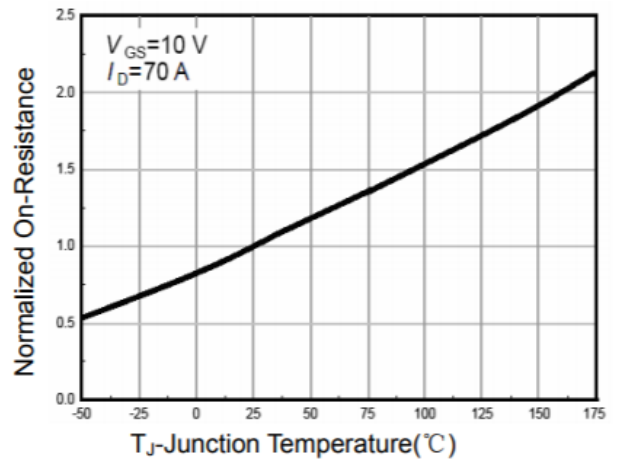


Figure 4 Rds(on)-Junction Temperature

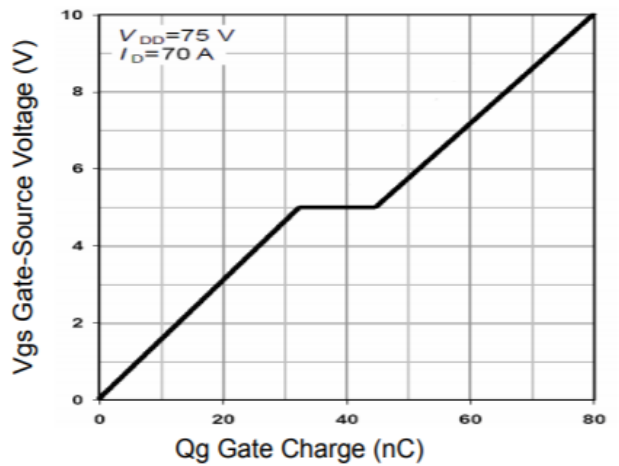


Figure 5 Gate Charge

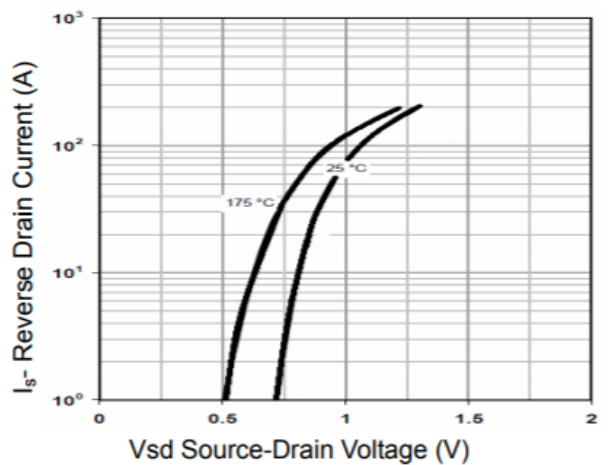


Figure 6 Source- Drain Diode Forward

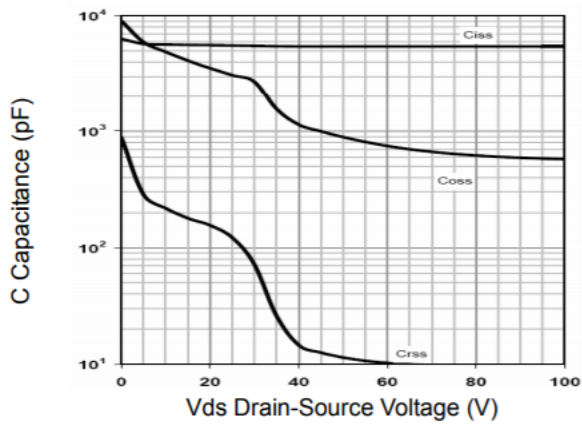


Figure 7 Capacitance vs Vds

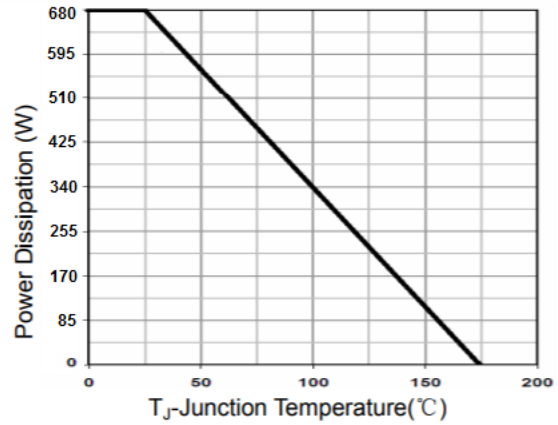


Figure 9 Power De-rating

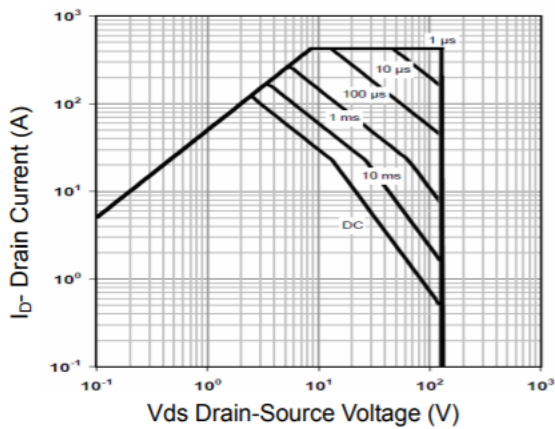


Figure 8 Safe Operation Area

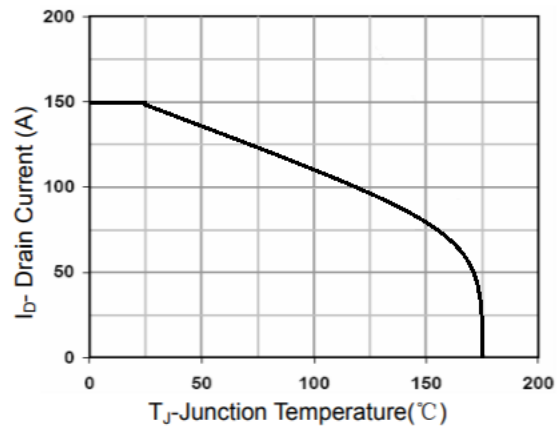


Figure 10 Current De-rating

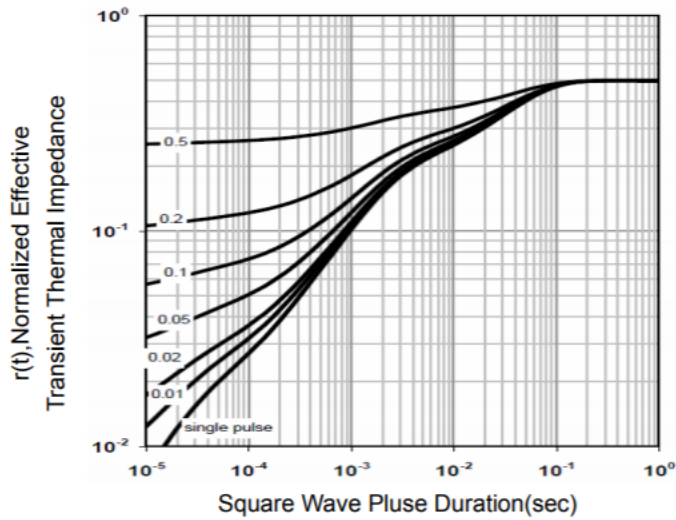


Figure 11 Normalized Maximum Transient Thermal Impedance